

Features

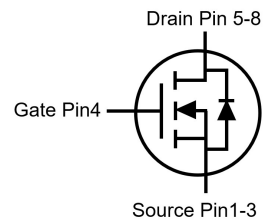
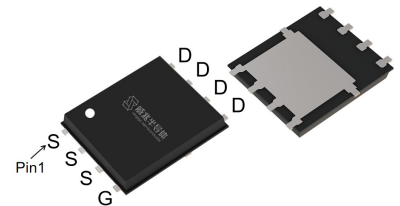
- Enhancement mode
- Ultra low on-resistance
- VitoMOS[®] II Technology
- Fast Switching and High efficiency
- 100% Avalanche tested, 100% Rg tested



Part ID	Package Type	Marking	Packing
VS3602GPMT	PDFN5x6	3602GPM	3000PCS/Reel

V_{DS}	30	V
$R_{DS(on),TYP@ V_{GS}=10V}$	0.6	mΩ
$R_{DS(on),TYP@ V_{GS}=4.5V}$	0.9	mΩ
$I_D(\text{Silicon Limited})$	440	A
$I_D(\text{Package Limited})$	200	A

PDFN5x6



Maximum ratings, at $T_A = 25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter		Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage		30	V
V_{GS}	Gate-Source voltage		± 20	V
I_S	Diode continuous forward current	$T_C = 25^\circ\text{C}$	440	A
I_D	Continuous drain current @ $V_{GS}=10V$ (Silicon limited)	$T_C = 25^\circ\text{C}$	440	A
I_D	Continuous drain current @ $V_{GS}=10V$ (Silicon limited)	$T_C = 100^\circ\text{C}$	278	A
I_D	Continuous drain current @ $V_{GS}=10V$ (Package limited)	$T_C = 25^\circ\text{C}$	200	A
I_{DM}	Pulse drain current tested ①	$T_C = 25^\circ\text{C}$	1150	A
I_{DSM}	Continuous drain current @ $V_{GS}=10V$	$T_A = 25^\circ\text{C}$	46	A
		$T_A = 70^\circ\text{C}$	37	A
E_{AS}	Avalanche energy, single pulsed ②		1225	mJ
P_D	Maximum power dissipation ③	$T_C = 25^\circ\text{C}$	240	W
		$T_C = 100^\circ\text{C}$	96	W
P_{DSM}	Maximum power dissipation ④	$T_A = 25^\circ\text{C}$	2.6	W
		$T_A = 70^\circ\text{C}$	1.7	W
$T_{STG,TJ}$	Storage and Junction Temperature Range		-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case ⑤	0.43	0.52	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient ⑥	40	48	$^\circ\text{C}/\text{W}$

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_j=25°C (unless otherwise stated)						
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	30	--	--	V
IDSS	Zero Gate Voltage Drain Current(T _j =25°C)	V _{DS} =30V, V _{GS} =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T _j =125°C) ^⑦	V _{DS} =30V, V _{GS} =0V	--	--	100	μA
IGSS	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.3	1.8	2.4	V
R _{DS(on)}	Drain-Source On-State Resistance ^⑧	V _{GS} =10V, I _D =40A	--	0.6	0.8	mΩ
		(T _j =100°C) ^⑦	--	0.8	--	mΩ
R _{DS(on)}	Drain-Source On-State Resistance ^⑧	V _{GS} =4.5V, I _D =30A	--	0.9	1.2	mΩ
Dynamic Electrical Characteristics @ T_j = 25°C (unless otherwise stated)						
C _{iss}	Input Capacitance ^⑦	V _{DS} =15V, V _{GS} =0V, f=1MHz	--	8540	--	pF
C _{oss}	Output Capacitance ^⑦		--	4395	--	pF
C _{rss}	Reverse Transfer Capacitance ^⑦		--	240	--	pF
R _g	Gate Resistance	f=1MHz	--	4.7	--	Ω
Q _{g(10V)}	Total Gate Charge ^⑦	V _{DS} =15V, I _D =40A, V _{GS} =10V	--	112	--	nC
Q _{g(4.5V)}	Total Gate Charge ^⑦		--	53	--	nC
Q _{gs}	Gate-Source Charge ^⑦		--	23	--	nC
Q _{gd}	Gate-Drain Charge ^⑦		--	14	--	nC
Switching Characteristics ^⑦						
T _{d(on)}	Turn-on Delay Time	V _{DD} =15V, I _D =40A, R _G =3Ω, V _{GS} =10V	--	9.4	--	ns
T _r	Turn-on Rise Time		--	105	--	ns
T _{d(off)}	Turn-Off Delay Time		--	142	--	ns
T _f	Turn-Off Fall Time		--	75	--	ns
Source- Drain Diode Characteristics @ T_j = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =40A, V _{GS} =0V	--	0.9	1.2	V
T _{rr}	Reverse Recovery Time ^⑦	I _{SD} =40A, V _{GS} =0V di/dt=100A/μs	--	59	--	ns
Q _{rr}	Reverse Recovery Charge ^⑦		--	50	--	nC

NOTE:

- ① Single pulse; pulse width ≤ 100μs.
- ② EAS of 1225mJ is based on starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = 70A, V_{GS} = 10V; 100% FT tested at L = 0.5mH, I_{AS} = 35A.
- ③ The power dissipation P_d is based on T_J(max), using junction-to-case thermal resistance R_{θJC}.
- ④ The power dissipation P_{dsm} is based on T_J(max), using junction-to-ambient thermal resistance R_{θJA}.
- ⑤ Thermal resistance from junction to soldering point (on the exposed drain pad).
- ⑥ These tests are performed with the device mounted on 1 in2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.
- ⑦ Guaranteed by design, not subject to production testing.
- ⑧ Pulse width ≤ 380μs; duty cycles ≤ 2%.

Typical Characteristics

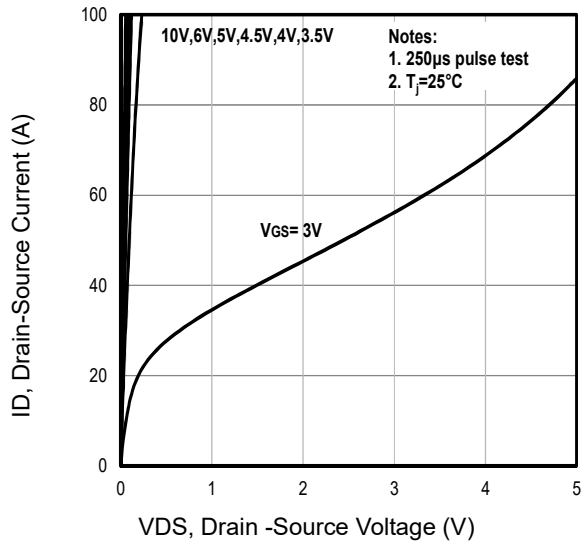


Fig1. Typical Output Characteristics

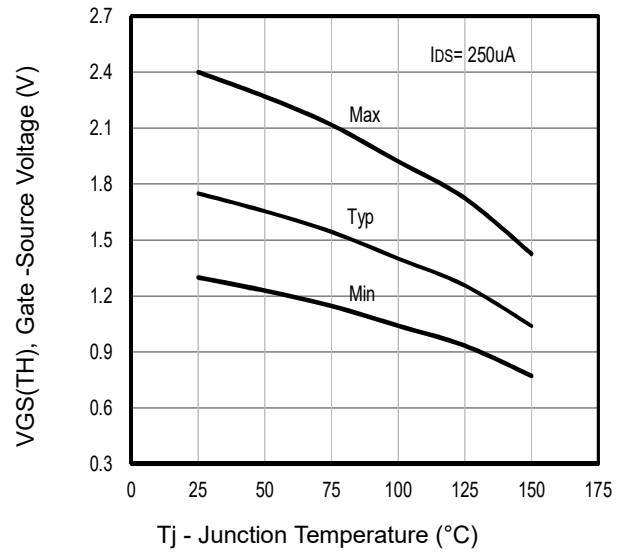


Fig2. Typical $V_{GS(TH)}$ Gate-Source Voltage Vs. T_j

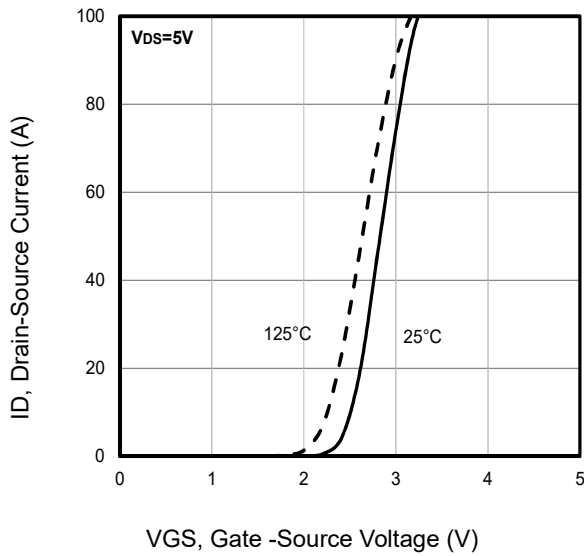


Fig3. Typical Transfer Characteristics

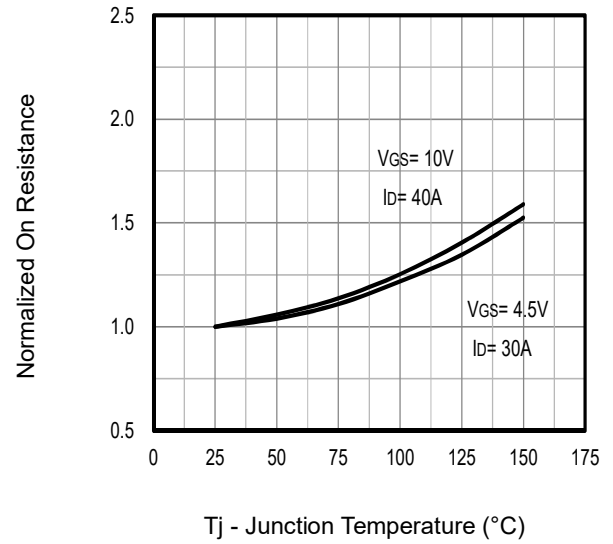


Fig4. Typical Normalized On-Resistance Vs. T_j

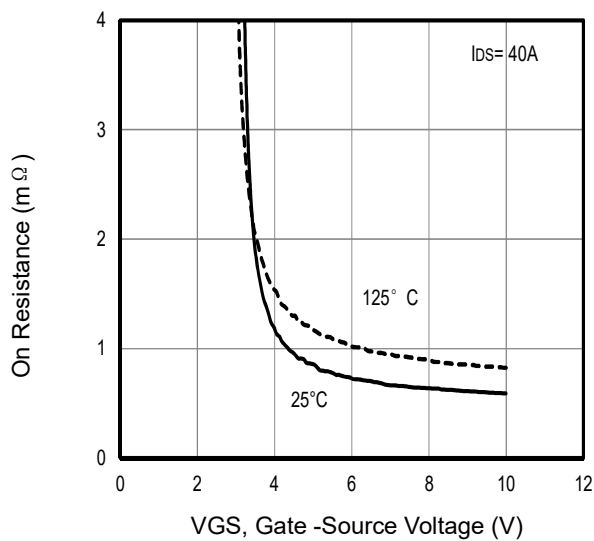


Fig5. Typical On Resistance Vs Gate-Source Voltage

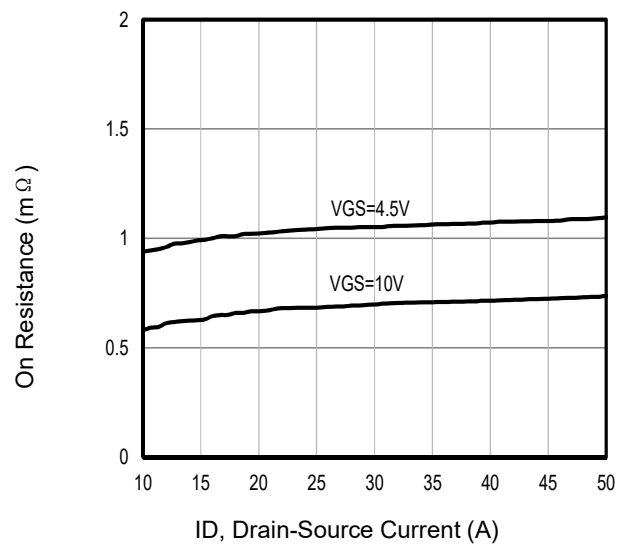


Fig6. Typical On Resistance Vs Drain Current

Typical Characteristics

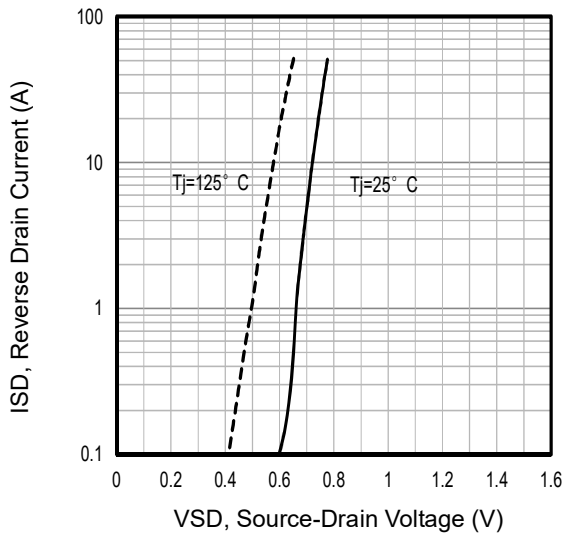


Fig7. Typical Source-Drain Diode Forward Voltage

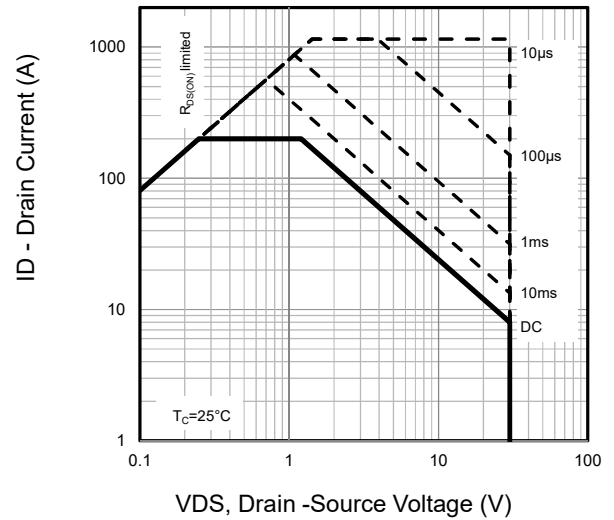


Fig8. Maximum Safe Operating Area

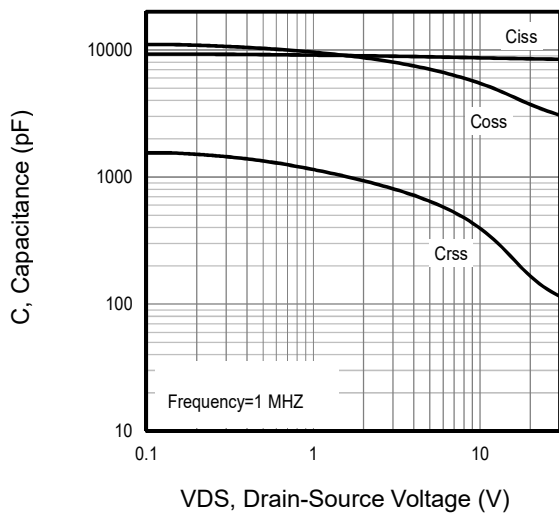


Fig9. Typical Capacitance Vs. Drain-Source Voltage

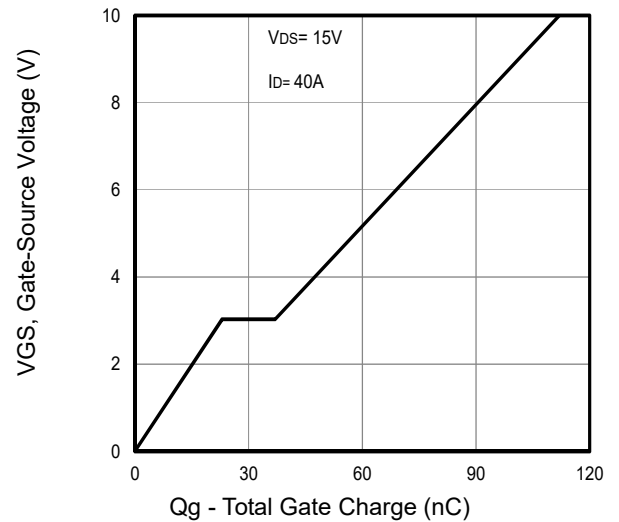


Fig10. Typical Gate Charge Vs. Gate-Source Voltage

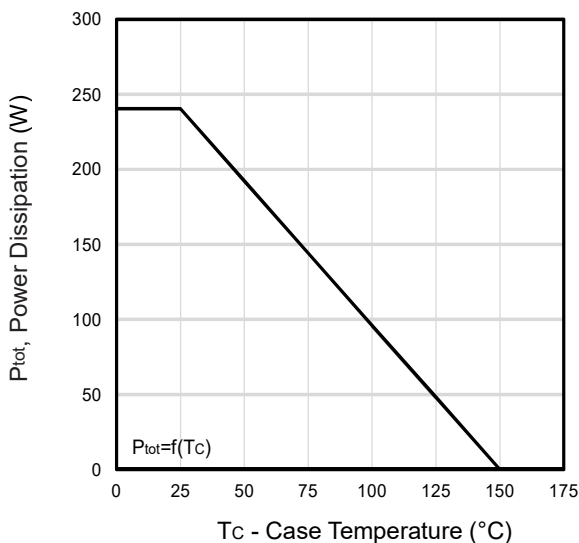


Fig11. Power Dissipation Vs. Case Temperature

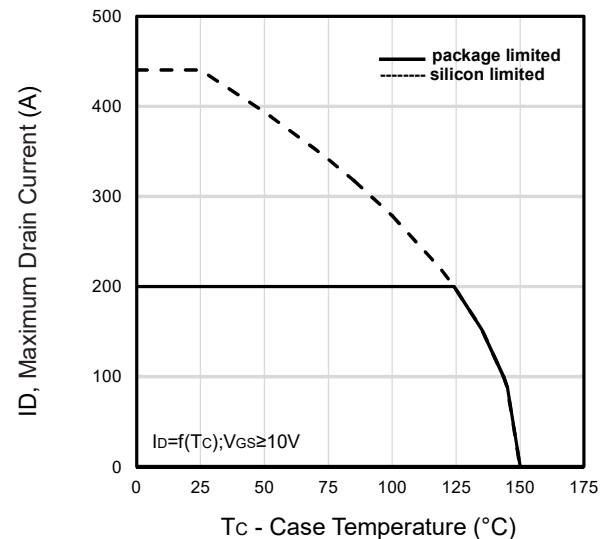


Fig12. Maximum Drain Current Vs. Case Temperature

Typical Characteristics

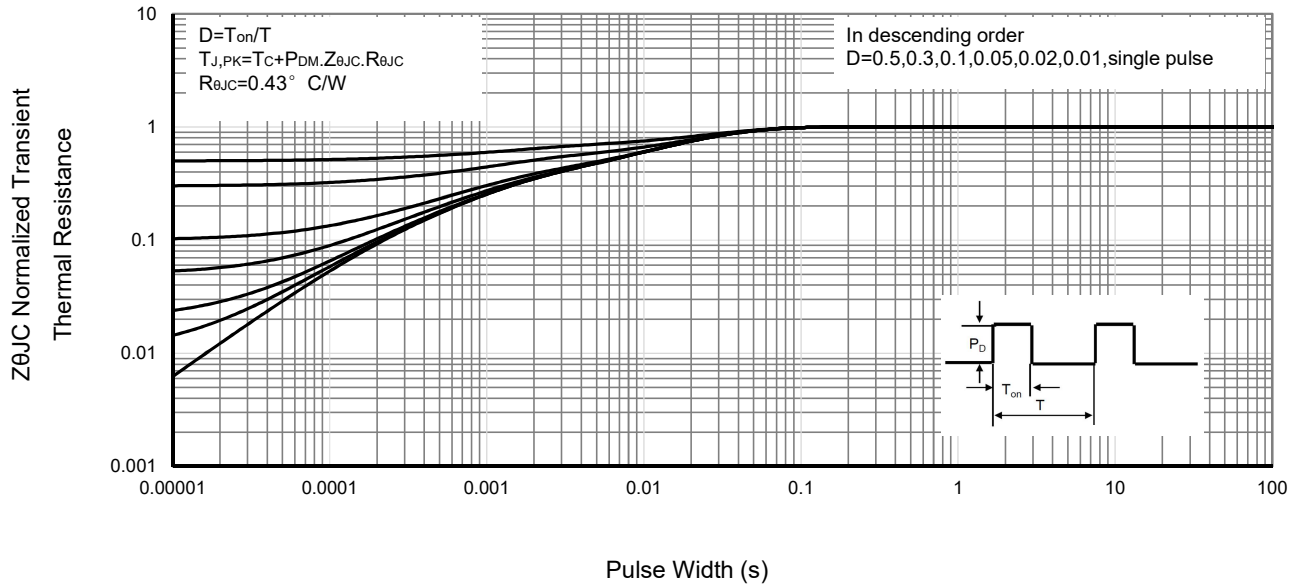


Fig13 . Normalized Maximum Transient Thermal Impedance

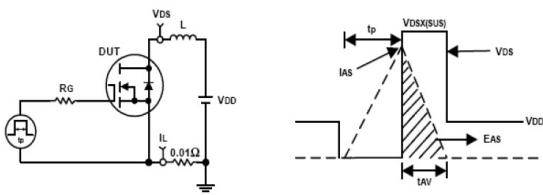


Fig14. Unclamped Inductive Test Circuit and waveforms

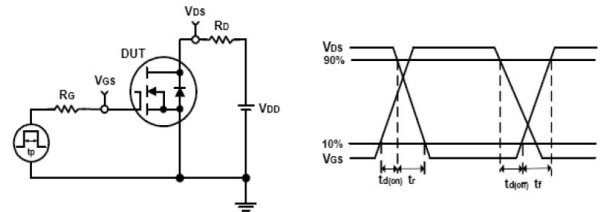
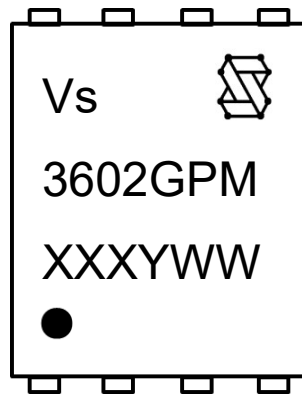


Fig15. Switching Time Test Circuit and waveforms

Marking Information



1st line: Vergiga Code (Vs) , Vergiga Logo

2nd line: Part Number (3602GPM)

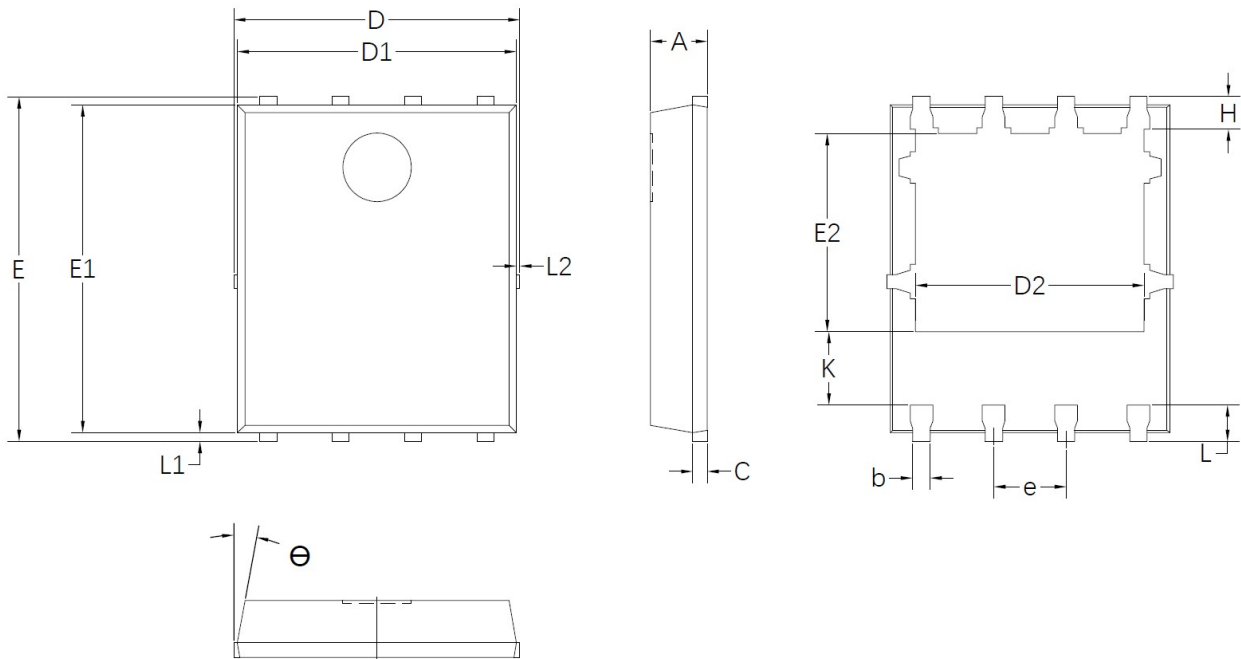
3rd line: Date code (XXXYWW)

XXX: Wafer Lot Number Code, code changed with Lot Number

Y: Year Code , refer to table below

WW: Week Code (01 to 53)

Code	C	D	E	F	G	H	J	K	L	M	N	P	Q	R	S	T
Year	2015	2016	2017	2018	2019	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030

PDFN5x6 Package Outline Data


Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	0.90	1.00	1.10
b	0.35	0.40	0.45
C	0.21	0.25	0.34
D	--	--	5.10
D1	4.80	4.90	5.00
D2	3.91	4.01	4.11
e	1.27 BSC		
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.375	3.475	3.575
H	0.55	0.65	0.75
K	1.29	--	--
L	0.55	0.65	0.75
L1	0.05	0.15	0.25
L2	--	--	0.12
θ	8°	10°	12°

Notes:

- 1.Refer to JEDEC MO-240 variation AA.
- 2.Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.
- 3.Dimensions "D1" and "E1" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.

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